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# N-Channel 60 V (D-S) Super Junction Power MOSFET

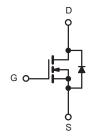
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ )(Typ.)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
60	1.5 at V <sub>GS</sub> = 10 V	220	205 nC			
00	2 at V <sub>GS</sub> = 4.5 V	220	205 NC			

#### **FEATURES**

- DT-SJ Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Low RDS(ON)
- · RoHS and Halogen-Free Compliant

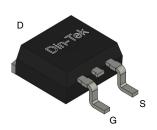
### APPLICATIONS

- High Frequency Switching and Synchronous Rectification
- BLDC



N-Channel MOSFET

TO-263	Pin	Configuration
	Ton	View



ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage	V <sub>DS</sub>	60	V			
Gate-Source Voltage	V <sub>GS</sub>	± 20	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \			
Continuous Proin Current /T = 475 °C\a	T <sub>C</sub> = 25 °C	1	220	А		
Continuous Drain Current (T <sub>J</sub> = 175 °C) <sup>a</sup>	T <sub>C</sub> = 100 °C	I <sub>D</sub>	190			
Pulsed Drain Current <sup>b</sup>	I <sub>DM</sub>	800				
Single Avalanche Energy	E <sub>AS</sub>	1900	mJ			
Maximum Power Dissipation <sup>c</sup>	T <sub>C</sub> = 25 °C	PD	263	W		
Maximum Fower Dissipation	T <sub>C</sub> = 100 °C		131	T vv		
Operating Junction and Storage Temperature R	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C			

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) <sup>d</sup>	$R_{thJA}$	50	°C/W		
Junction-to-Case (Drain)	R <sub>thJC</sub>	0.57			

#### Notes

- a. Calculated continuous current based on maximum allowablejunction temperature.
- b. Repetitive rating; pulse width limited by max. junction temperature.
- c.  $\,$  Pd is based on max. junction temperature, using junction-case thermal resistance.
- d. The value of R<sub>8JA</sub> is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper,in a still air environment with Ta=25 °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	60	-	-	V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	1	-	3		
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V -		-	1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 125 ^{\circ}\text{C}$	-	-	50	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 10 V	220	-	-	Α	
Drain-Source On-State Resistance <sup>a</sup>	D ·	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	1.5	2.2	0	
Diain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 15 A		2	3	mΩ	
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	$V_{DS} = 5 \text{ V}, I_{D} = 20 \text{ A}$	-	50	-	S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>		-	11500	-	pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$	-	2480	-		
Reverse Transfer Capacitance	C <sub>rss</sub>		-	205	-		
Total Gate Charge <sup>c</sup>	Qg		-	205	-	nC	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	25	-		
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>		-	43	-		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	-	0.8	-	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>		-	40	-		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 30 \text{ V}, I_D = 20 \text{ A}, R_g = 2.5 \Omega$	-	24	-		
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$V_{GS}$ = 10 $V$ , $R_L$ = 1.5 $\Omega$	-	108	-	ns -	
Fall Time c	t <sub>f</sub>		-	30	-		
Drain-Source Body Diode Ratings and	Characterist	ics <sup>b</sup> (T <sub>C</sub> = 25 °C)					
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	220	Α	
Pulsed Current	I <sub>SM</sub>		-	-	800	Α	
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 1 A, V <sub>GS</sub> = 0 V	-	-	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>	1 - 20 A di/dt = 400 A/vic	-	33	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	80	-	nC	

#### Notes

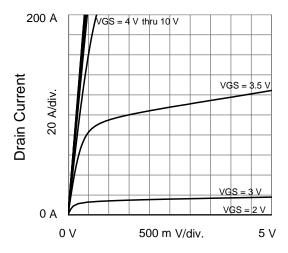
- a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those in dicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended pe riods may affect device reliability.

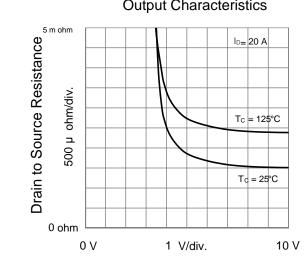




#### TYPICAL CHARAC TERISTICS (25 °C, unless otherwise noted)

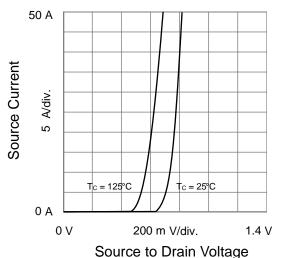


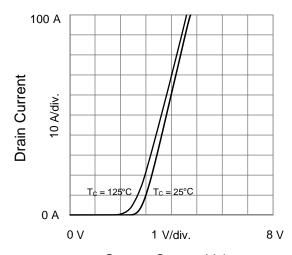
Drain to Source Voltage Output Characteristics



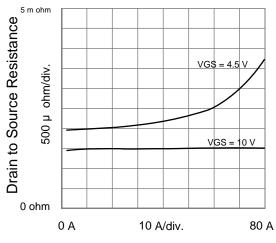
Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltag

**Body Diode Forward Characteristics** 

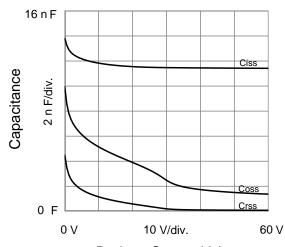




Gate to Source Voltage Transfer Characteristics



**Drain Current** 

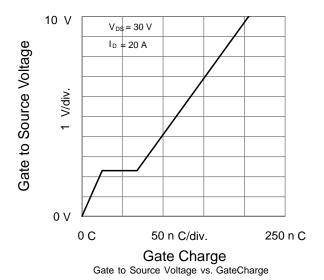


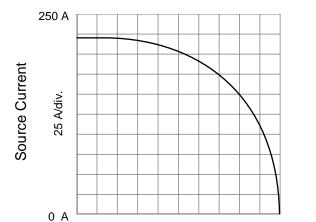
Drain to Source Voltage Capacitances





#### TYPICAL CHARAC TERISTICS (25 °C, unless otherwise noted)

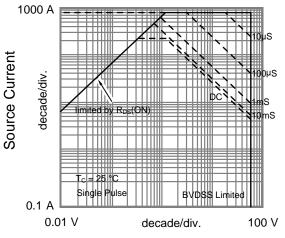




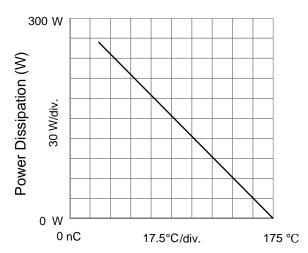
0 nC

17.5 °C/div. T<sub>C</sub> - Case Temperature

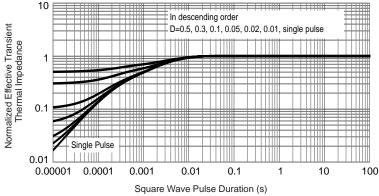
175 °C



Source to Drain Voltage Safe Operating Area, Junction-to-Case



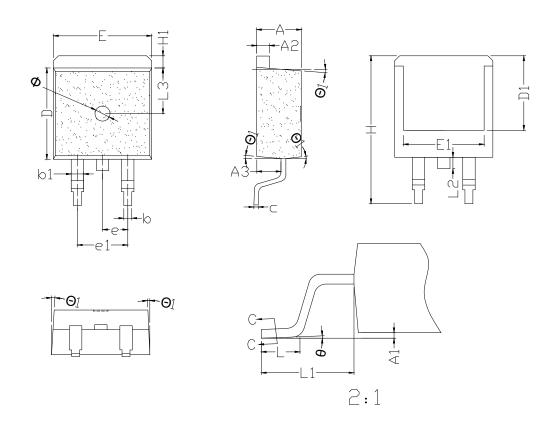
T<sub>C</sub> - Case Temperature



Normalized Thermal Transient Impedance, Junction-to-Case



# **TO-263 PACKAGE OUTLINE**



COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	SYMBOL	MIN	TYP	MAX
Α	4.10	4.50	4.80	е	2.35	2.54	2.75
A1	0.00	0.10	0.30	e1	5.08REF		
A2	1.10	1.30	1.50	Н	14.50	15.15	16.00
А3	2.15	2.50	3.10	H1	1.00	1.28	1.75
b	0.60	0.80	1.05	L	1.80	2.23	2.90
b1	1.05	1.33	1.50	L1	4.30	4.75	5.50
С	0.33	0.50	0.66	L2	1.00	1.30	1.85
D	8.40	9.20	9.60	L3	0.90	4.65	9.00
D1	7.50REF			ф	0°	2°	5°
Е	9.60	10.02	10.80	ф1	2°	-	7°
E1	7.60	9.88	10.30	Ф	1.5BSC		





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